

<b>Notice of References Cited</b>	Application/Control No. 10/825,453	Applicant(s)/Patent Under Reexamination MISHRA ET AL.	
	Examiner Hoan H. Tran	Art Unit 2852	Page 1 of 1

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	B	US-6,531,227	03-2003	van den Reek et al.	428/411.1
	C	US-5,382,486	01-1995	Yu et al.	430/56
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	L	US-			
	M	US-			

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